

Notice of References Cited	Application/Control No. 10/567,320	Applicant(s)/Patent Under Reexamination HADDEN, JOHN W.	
	Examiner SHARON WEN	Art Unit 1644	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Weiner et al. PNAS 1997, 94:10833-10837
	V	
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